

FEATURES

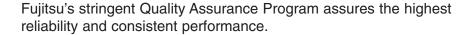
• High Output Power: P_{1dB} = 31.5dBm (Typ.)

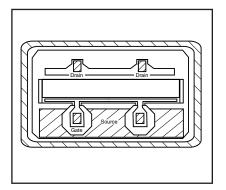
• High Gain: $G_{1dB} = 6.0dB(Typ.)$ • High PAE: $\eta_{add} = 29.5\%(Typ.)$

Proven Reliability

DESCRIPTION

The FLC157XP chip is a power GaAs FET that is designed for general purpose applications in the C-Band frequency range as it provides superior power, gain, and efficiency.





ABSOLUTE MAXIMUM RATING (Ambient Temperature Ta=25°C)

Item	Symbol	Condition	Rating	Unit	
Drain-Source Voltage	VDS		15	V	
Gate-Source Voltage	VGS		-5	V	
Total Power Dissipation	Ptot	T _C = 25°C	8.3	W	
Storage Temperature	T _{stg}		-65 to +175	°C	
Channel Temperature	T _{ch}		175	°C	

Fujitsu recommends the following conditions for the reliable operation of GaAs FETs:

- 1. The drain-source operating voltage ($V_{\mbox{DS}}$) should not exceed 10 volts.
- 2. The forward and reverse gate currents should not exceed 9.6 and -1.0 mA respectively with gate resistance of 200 Ω .
- 3. The operating channel temperature (T_{ch}) should not exceed 145°C.

ELECTRICAL CHARACTERISTICS (Ambient Temperature Ta=25°C)

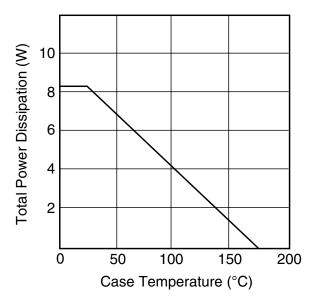
Ham	Comple ed	Took Conditions	Limit			11!4
Item	Symbol	Test Conditions	Min.	Тур.	Max.	Unit
Saturated Drain Current	IDSS	V _{DS} = 5V, V _{GS} = 0V	-	600	900	mA
Transconductance	9m	$V_{DS} = 5V, I_{DS} = 400 \text{mA}$	150	300	-	mS
Pinch-off Voltage	Vp	$V_{DS} = 5V$, $I_{DS} = 30mA$	-1.0	-2.0	-3.5	V
Gate Source Breakdown Voltage	V _{GSO}	I _{GS} = -30μA	-5	-	-	V
Output Power at 1dB Gain Compression Point	P _{1dB}		30.5	31.5	-	dBm
Power Gain at 1dB Gain Compression Point	G _{1dB}	VDS = 10V IDS ≈ 0.6IDSS f = 8GHz	5.0	6.0	-	dB
Power-added Efficiency	ηadd		-	29.5	-	%
Thermal Resistance	R _{th}	Channel to Case	-	15	18	°C/W

Note: RF parameter sample size 10pcs. criteria (accept/reject)=(2/3)

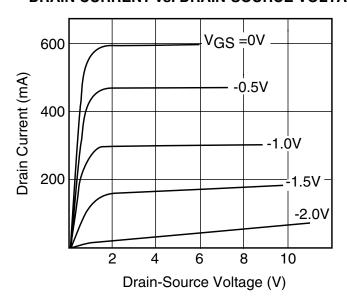
The chip must be enclosed in a hermetically sealed environment for optimum performance and reliability.



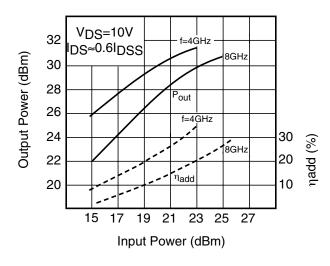
POWER DERATING CURVE



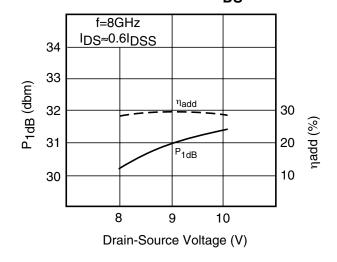
DRAIN CURRENT vs. DRAIN-SOURCE VOLTAGE



OUTPUT POWER vs. INPUT POWER



P1dB & η add vs. VDS





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S-PARAMETERS

 $V_{DS} = 10V, I_{DS} = 400mA$

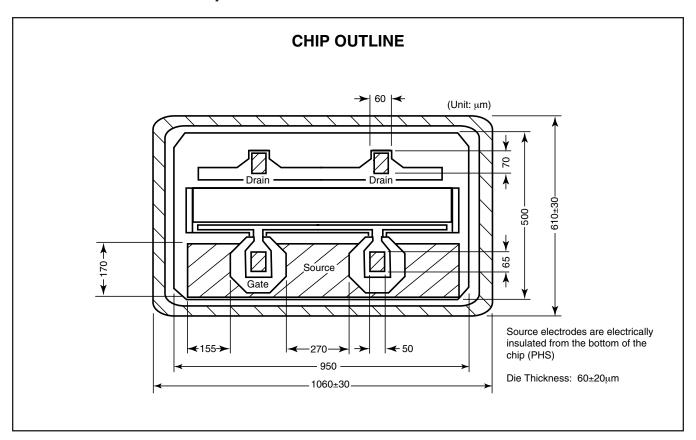
FREQUENCY	S11		S21		S1	S12		S22	
(MHZ)	MAG	ANG	MAG	ANG	MAG	ANG	MAG	ANG	
100	.993	-25.9	15.864	165.0	.013	76.4	.185	-39.7	
500	.918	-98.4	10.322	123.1	.041	40.2	.293	-115.6	
1000	.881	-134.6	6.162	100.0	.049	24.2	.337	-139.9	
2000	.868	-159.5	3.250	77.3	.051	15.8	.375	-150.6	
3000	.868	-169.8	2.178	61.7	.051	14.8	.413	-152.6	
4000	.871	-176.3	1.625	48.3	.050	16.3	.456	-153.5	
5000	.875	178.9	1.284	36.0	.050	19.3	.503	-154.9	
6000	.881	174.8	1.051	24.6	.050	23.3	.550	-156.8	
7000	.886	171.2	.878	13.8	.052	27.9	.597	-159.3	
8000	.892	167.8	.743	3.7	.054	32.5	.641	-162.2	
9000	.897	164.6	.633	-5.8	.057	36.7	.682	-165.4	
10000	.903	161.5	.541	-14.6	.061	40.2	.720	-168.7	
11000	.907	158.4	.462	-22.9	.067	42.8	.753	-172.1	
12000	.912	155.5	.393	-30.5	.072	44.6	.783	-175.6	

NOTE:* The data includes bonding wires.

n: number of wires Gate n=2 (0.3mm length, 25µm Dia Au wire)

Drain n=2 (0.3mm length, 25μm Dia Au wire) Source n=4 (0.3mm length, 25μm Dia Au wire)





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